


<b>Search Notes</b>  	<b>Application/Control No.</b>  10537102	<b>Applicant(s)/Patent Under Reexamination</b>  KUJA-PANULA ET AL.
	<b>Examiner</b>  Wang, Chang-Yu	<b>Art Unit</b>  1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
sequence search: SEQ ID NO:2. See search results in SCORE (1/23/07)	1/22/07	CYW
EAST, STN: search strategy attached.	3/5/07	CYW
Inventor name search: EAST, STN, PALM	3/5/07	CYW
PLUS search from STIC. See search results in eDAN (1/22/07)	1/22/07	CYW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner